Notice of References Cited Application/Control No. 10/084,019 Applicant(s)/Patent Under Reexamination TIEDEMANN ET AL. Examiner VENKATESH HALIYUR Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0044531	04-2002	Cooper et al.	370/248
*	В	US-7,042,957	05-2006	Zirwas, Wolfgang	375/295
*	С	US-6,160,791	12-2000	Bohnke, Ralf	370/208
*	D	US-6,452,914	09-2002	Niemela, Kari	370/337
*	Е	US-6,463,295	10-2002	Yun, Louis C.	455/522
*	F	US-6,597,923	07-2003	Vanghi et al.	455/522
*	G	US-6,763,244	07-2004	Chen et al.	455/522
*	H	US-6,285,886	09-2001	Kamel et al. 455/52	
*	I	US-7,143,320	11-2006	Cavin, Robert D.	714/704
	J	US-		-	
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	σ					
	R					
	s					
	Τ			2-12-3-6	ı C.	

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.